

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application of:

Docket No.: 34170

Maurice Lee Smith et al.

Group Art Unit No.: 1631

Serial No.: 10/672,210

Filed: 9/26/03

SYSTEM AND METHOD FOR IDENTIFYING,

REPORTING, AND EVALUATING

PRESENCE OF SUBSTANCE

Examiner:

#### **TRANSMITTAL**

Transmitted herewith are: Transmittal; Information Disclosure Statement (1 page); Information Disclosure Statement by Application PTO Form 1449 (2 pages); and return postcard.

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by

Express Mail No.

Respectfully submitted,

HOVEY WILLIAMS LLP

Dated: April 30, 2004

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Examiner:

Assistant Commissioner of Patents Washington, D.C. 20231

Sir:

### <u>INFORMATION DISCLOSURE STATEMENT</u>

The attached references are being filed to fulfill the duty of candor and good faith toward the Patent and Trademark Office, as required by 37 C.F.R. §1.56.

Any fee which is due in connection with this Statement should be applied against Deposit Account No. 19-0522.

Respectfully submitted,

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FORM PTO-1449 (Rev 2-92)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 34170	SERIAL NO. 10/672,210				
APR 3 0 2004	RMATION DISCLOSURE EMENT BY APPLICANT	APPLICANT: Maurice Lee Smith et al.					
se s	everal sheets if necessary)	FILING DATE: 9/26/2003	GROUP: 1631				

# **U.S. PATENT DOCUMENTS**

EXAM. INITIAL	DOCUMENT NUMBER							DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	6	6	2	8	9	4	1	9/30/03	Knoblach et al.			
	6	6	0	8	5	5	9	8/19/03	Lemelson et al.			
	6	5	8	8	7	0	1	7/08/03	Yavnai			
	 6	4	9	8	0	4	1	12/24/02	Tabacco et al.			
	6	4	9	0	5	3	0	12/03/02	Wyatt			
	6	4	4	6	0	0	4	9/03/02	Cao et al.			
	6	3	5	6	6	2	5	3/12/02	Castellani et al.			
	6	3	2	7	5	3	5	12/04/01	Evans et al.			
	6	3	1	7	0	8	0	11/13/01	Baxter, Jr.			
	6	1	6	9	4	7	6	01/02/01	Flanagan			
	6	0	8	3	2	4	8	7/04/00	Thompson			
	6	0	7	5	8	9	1	6/13/00	Burman			
	6	0	5	2	1	8	7	4/18/00	Krishnan et al.			
	6	0	2	3	2	2	3	2/08/00	Baxter, Jr.			
	5	9	7	2	6	3	8	10/26/99	Burlage et al.			
	5	9	3	8	7	2	1	8/17/99	Dussell et al.			
	5	8	3	8	2	3	7	11/17/98	Revell et al.	- "		
	5	6	5	0	8	0	0	7/22/97	Benson			
	5	6	4	8	9	1	4	7/15/97	Bauer et al.			
	5	5	2	8	2	4	8	6/18/96	Steiner et al.			
	5	4	7	0	2	3	3	11/28/95	Fruchterman et al.			
	5	4	4	4	4	4	4	8/22/95	Ross			
	4	8	6	1	7	2	7	8/29/89	Hauenstein et al.			
			н	1	3	4	4	4/02/94	Baldauf et al.			:

## **FOREIGN PATENT DOCUMENTS**

	DO	осим	ENT N	IUMBE	R	DATE	COUNTRY	CLASS	SUBCLASS	TRANSL	ATION
										YES	NO

FORM PTO-1449 (Rev. 2-32)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE					
	MATION DISCLOSURE EMENT BY APPLICANT	APPLICANT: Maurice Lee Smith et al.				
(Use sev	veral sheets if necessary)	FILING DATE: 9/26/2003	GROUP: 2878			

# OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	"Oak Ridge claims sensitivity record for Si MEMS sensor"; June 23, 2003 article in Electronic Engineering Times; Author R. Colin Johnson, page 49.

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.